ATTY. DOCKET NO. SERIAL NO. Form PTO-1449 U.S. Department of Commerce Patent and Trademark Office PU60173 10/551,710 APPLICANT INFORMATION DISCLOSURE STATEMENT Conde et al. **BY APPLICANT** FILING DATE GROUP (Use several sheets if necessary) October 3, 2005 1624

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
/BK/	6,825,188 B2	11/30/04	Callahan et al.	514	212.07	
	5,202,473 A	4/13/93	Chan et al.	562	496	
	4,939,288	7/3/90	John J. Talley	560	81	
	4,080,450	3/21/78	Croisier et al.	424	244	
000000000000000000000000000000000000000	5,508,435 A	4/16/96	Armstrong, III et al.	548	543	
	5,596,113 A	1/21/97	Douglas et al.	556	14	
00000	4,691,037	9/1/87	Yoshikawa et al.	556	18	
V	5,939,412	8/17/99	Bondinell et al.	514	213	

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	<u>Trans</u> Yes	lation No
/BK/	WO 00/63186	10/26/00	wo				
/BK/	10130175	10/31/96	JP			Abst.	_

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/BK/	Morimoto et al. Tet. Letters, 30: 735-738 (1989).						
8889	Cabri et al. Acc. Chem. Res., 28: 2-7 (1995).						
999999	De Meijere et al. Angew. Chem. Int. Ed. Engl., 33: 2379-2411 (1994).						
000000	McGuire et al. Tet. Letters, 40(17): 3293-3296 (1999).						
00000	White et al. J. Org. Chem., 62: 5250-5251 (1997).						
0000000	DiMichele et al. Tetrahedron: Asymmetry, 14: 3427-3429 (2003).						
0000000	Wallace et al. Org. Process Res. & Dev., 8: 738-743 (2004).						
000000	Leitner et al. J. Am. Chem. Soc., 115(1): 152-159 (1993).						
	Saburi et al. J. Organomet. Chem., 428(1-2): 155-167 (1992).						
	Ito et al. Tetrahedron Lett., 31(19): 2731-2734 (1990).						
-	Kawano et al. Tetrahedron Lett., 28(17): 1905-1908 (1987).						
00000000	Mathey et al. J. Organomet. Chem., 557(1): 117-120 (1998).						
V	Shao et al. J. Chem. Soc. Perkin Trans., 1(5): 1441-1445 (1990).						
EXAMINER /Br	ruck Kifle/ (12/20/2007)	DATE CONSIDERED 12/20/2007					

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copyof this form with next communication to applicant.

Sheet 2 of 2

			ment of Commerce d Trademark Office			, ,	Sheet 2 of 2 . SERIAL NO. 10/551,710		
INFOR	MATION DISCLOSUR BY APPLICAN		ΓΑΤΕ	MENT	APPLICANT Conde et al.				
(Use several sheets if necessary)				FILING DATE October 3, 2005		GROUP 1624			
					NT DOCUMENTS				
Examiner Initial	Document Number	er		ate	Name	Class	Subclass	Filing Date If Appropriate	
/BK/	US2002/0032187	A1	3/14	/02	Fred H. Drake	514	211.06		
XXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXX	6,825,188 B2		11/3	0/04	Callahan et al.	514	212.07		
	US2002/0147334A1		10/10/02		Miller et al.	540	553		
V	6,576,643 B2		6/10/	/03	Bondinell et al.	514	310		
		. //							
			FORE	IGN PAT	TENT DOCUMENTS				
	Document Number	Da	ate 	Country		Class	Subclass	Translation Yes No	
				<u> </u>					
				1					
!]					
									
					· , · · · · · · · · · · · · · · · · · ·				
(5).(/	OTHER DOC	CUME	ENTS	(Including	Author, Title, Date, Pertine	ent Pages, Etc	c.)		
/BK/	,				<u>35(1-2)</u> : 133-147 (199:				
	Kawano et al. J. o	Chen	ı. Soc	. Perkin	<i>Trans.</i> , <u>1</u> : 1571-1575	(1989).	<u></u>		
	Miller et al. J.Me	<i>d. Cl</i>	hem.,	<u>43(1)</u> : 2	2-26 (2000).				
EXAMINER					DATE CONSIDERED				
/Bruck Kifle/ (12/20/2007)			12/20/2007						
·EXAMINER:	Initial if citation considered	, whe					aw line throug	h citation if not	
in conformanc	ce and not considered. Incl	ude c	opyof t	his form v	vith next communication to	applicant.			